Pb Free Terminal Finish.

# **ULTRAFAST SOFT RECOVERY RECTIFIER DIODE**

## **PRODUCT APPLICATIONS**

- Anti-Parallel Diode

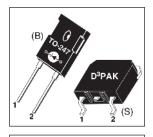
   Switchmode Power Supply
   Inverters
- Free Wheeling Diode
   -Motor Controllers
   -Converters
   -Inverters
- · Snubber Diode
- PFC

### **PRODUCT FEATURES**

- Ultrafast Recovery Times
- Soft Recovery Characteristics
- Popular TO-247 Package or Surface Mount D³PAK Package
- Low Forward Voltage
- Low Leakage Current
- Avalanche Energy Rated

### **PRODUCT BENEFITS**

- Low Losses
- · Low Noise Switching
- Cooler Operation
- · Higher Reliability Systems
- Increased System Power Density





- 1 Cathode
- 2 Anode Back of Case - Cathode

#### **MAXIMUM RATINGS**

All Ratings:  $T_C = 25$ °C unless otherwise specified.

Symbol	Characteristic / Test Conditions	APT40DQ60(B/S)G	UNIT	
V <sub>R</sub>	Maximum D.C. Reverse Voltage			
V <sub>RRM</sub>	Maximum Peak Repetitive Reverse Voltage	600	Volts	
V <sub>RWM</sub>	Maximum Working Peak Reverse Voltage			
I <sub>F(AV)</sub>	Maximum Average Forward Current (T <sub>C</sub> = 111°C, Duty Cycle = 0.5)	40		
I <sub>F(RMS)</sub>	RMS Forward Current (Square wave, 50% duty)	63	Amps	
I <sub>FSM</sub>	Non-Repetitive Forward Surge Current $(T_J = 45^{\circ}C, 8.3 \text{ms})$	320		
E <sub>AVL</sub>	Avalanche Energy (1A, 40mH)	20	mJ	
T <sub>J</sub> ,T <sub>STG</sub>	Operating and StorageTemperature Range	-55 to 175	°C	
T <sub>L</sub>	Lead Temperature for 10 Sec.	300		

## STATIC ELECTRICAL CHARACTERISTICS

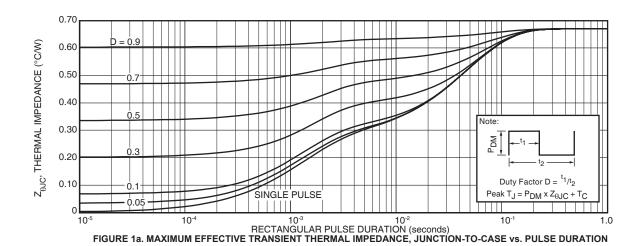
Symbol	Characteristic / Test Conditions		MIN	TYP	MAX	UNIT
V <sub>F</sub>	Forward Voltage	I <sub>F</sub> = 40A		2.0	2.4	Volts
		I <sub>F</sub> = 80A		2.5		
		I <sub>F</sub> = 40A, T <sub>J</sub> = 125°C		1.7		
I <sub>RM</sub>	Maximum Reverse Leakage Current	V <sub>R</sub> = 600V			25	μΑ
		$V_{R} = 600V, T_{J} = 125^{\circ}C$			500	
C <sub>T</sub>	Junction Capacitance, V <sub>R</sub> = 200V			36		pF

Symbol	Characteristic	Test Conditions	MIN	TYP	MAX	UNIT
t <sub>rr</sub>	Reverse Recovery Time I <sub>F</sub> = 1A, di <sub>F</sub> /dt =	$-100A/\mu s$ , $V_R = 30V$ , $T_J = 25^{\circ}C$	-	22		20
t <sub>rr</sub>	Reverse Recovery Time	$I_F = 40A$ , $di_F/dt = -200A/\mu s$ $V_R = 400V$ , $T_C = 25^{\circ}C$	-	25		ns
Q <sub>rr</sub>	Reverse Recovery Charge		-	35		nC
I <sub>RRM</sub>	Maximum Reverse Recovery Current		-	3	-	Amps
t <sub>rr</sub>	Reverse Recovery Time	$I_F = 40A$ , $di_F/dt = -200A/\mu s$ $V_R = 400V$ , $T_C = 125$ °C	-	160		ns
Q <sub>rr</sub>	Reverse Recovery Charge		-	480		nC
I <sub>RRM</sub>	Maximum Reverse Recovery Current		-	6	-	Amps
t <sub>rr</sub>	Reverse Recovery Time	$I_F = 40A$ , $di_F/dt = -1000A/\mu s$ $V_R = 400V$ , $T_C = 125°C$	-	85		ns
Q <sub>rr</sub>	Reverse Recovery Charge		-	920		nC
I <sub>RRM</sub>	Maximum Reverse Recovery Current		-	20		Amps

### THERMAL AND MECHANICAL CHARACTERISTICS

Symbol	Characteristic / Test Conditions	MIN	TYP	MAX	UNIT
$R_{\theta JC}$	Junction-to-Case Thermal Resistance			.67	°C/W
W <sub>T</sub>	Package Weight		0.22		oz
			5.9		g
Torque	Maximum Mounting Torque			10	lb•in
				1.1	N•m

APT Reserves the right to change, without notice, the specifications and information contained herein.



Power (watts)

Case temperature (°C)

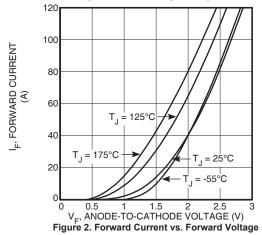
PC MODEL

0.289

0.00448

FIGURE 1b, TRANSIENT THERMAL IMPEDANCE MODEL

## **TYPICAL PERFORMANCE CURVES**



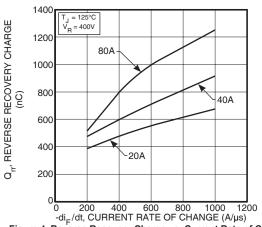
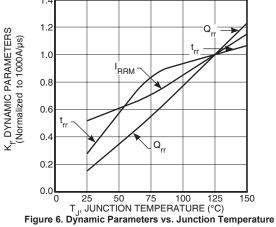
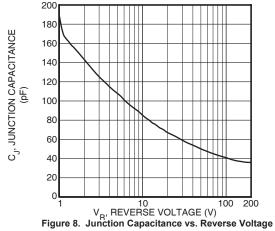


Figure 4. Reverse Recovery Charge vs. Current Rate of Change





## APT40DQ60(B/S)G

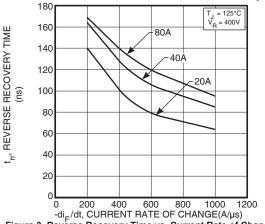


Figure 3. Reverse Recovery Time vs. Current Rate of Change

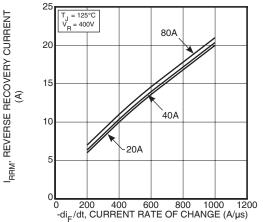


Figure 5. Reverse Recovery Current vs. Current Rate of Change

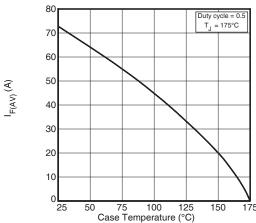


Figure 7. Maximum Average Forward Current vs. CaseTemperature

6

0.25 I<sub>RRM</sub>

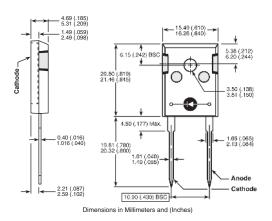
Slope =  $di_M/dt$ 

Figure 9. Diode Test Circuit

- 1 I<sub>F</sub> Forward Conduction Current
- 2 di<sub>F</sub>/dt Rate of Diode Current Change Through Zero Crossing.
- 3 I<sub>RBM</sub> Maximum Reverse Recovery Current.
- 4 t<sub>rr</sub> Reverse Recovery Time, measured from zero crossing where diode current goes from positive to negative, to the point at which the straight line through I<sub>RRM</sub> and 0.25•I<sub>RRM</sub> passes through zero.
- $\mathbf{5}$   $\mathbf{Q}_{rr}$  Area Under the Curve Defined by  $\mathbf{I}_{\mathsf{RRM}}$  and  $\mathbf{t}_{rr}$ .
- f 6 di<sub>M</sub>/dt Maximum Rate of Current Increase During the Trailing Portion of  $t_{rr.}$

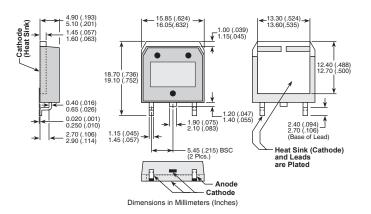
Figure 10, Diode Reverse Recovery Waveform and Definitions

# TO-247 Package Outline



# D<sup>3</sup>PAK Package Outline

(e3) 100% Sn







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